

1. Record Nr.	UNINA9910709716503321
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Titolo	Programmable, automated transistor test system // Long V. Truong and Gale R. Sundburg
Pubbl/distr/stampa	Washington, D.C. : , : National Aeronautics and Space Administration, Scientific and Technical Information Branch, , February 1986
Descrizione fisica	1 online resource (22 pages) : illustrations
Collana	NASA/TP ; ; 2554
Soggetti	Bipolar transistors Performance tests Field effect transistors Numerical control Software engineering Transistors - Testing - Computer programs Bipolar transistors - Testing - Computer programs Metal oxide semiconductors - Testing - Computer programs
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	"February 1986."
Nota di bibliografia	Includes bibliographical references (page 22).